

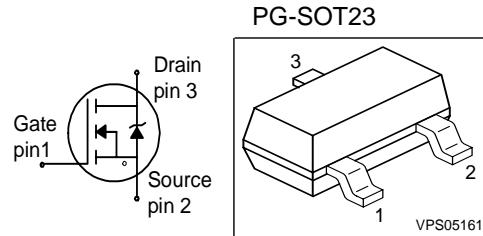
## SIPMOS® Small-Signal-Transistor

### Feature

- N-Channel
- Enhancement mode
- Logic Level
- $dV/dt$  rated
- Pb-free lead plating; RoHS compliant

### Product Summary

$V_{DS}$	100	V
$R_{DS(on)}$	6	$\Omega$
$I_D$	0.17	A



Type	Package	Pb-free	Tape and Reel Information	Marking
BSS119	PG-SOT23	Yes	L6327: 3000 pcs/reel	sSH

**Maximum Ratings**, at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

Parameter	Symbol	Value	Unit
Continuous drain current $T_A=25^\circ\text{C}$	$I_D$	0.17	A
$T_A=70^\circ\text{C}$		0.13	
Pulsed drain current $T_A=25^\circ\text{C}$	$I_{D \text{ puls}}$	0.68	
Reverse diode $dV/dt$ $I_S=0.17\text{A}, V_{DS}=80\text{V}, dI/dt=200\text{A}/\mu\text{s}, T_{jmax}=150^\circ\text{C}$	$dV/dt$	6	kV/ $\mu\text{s}$
Gate source voltage	$V_{GS}$	$\pm 20$	V
Power dissipation $T_A=25^\circ\text{C}$	$P_{\text{tot}}$	0.36	W
Operating and storage temperature	$T_j, T_{stg}$	-55... +150	$^\circ\text{C}$
IEC climatic category; DIN IEC 68-1		55/150/56	

### Thermal Characteristics

Parameter	Symbol	Values			Unit
		min.	typ.	max.	

### Characteristics

Thermal resistance, junction - ambient at minimal footprint	$R_{\text{thJS}}$	-	-	350	K/W
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### Electrical Characteristics, at $T_j = 25^\circ\text{C}$ , unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	

### Static Characteristics

Drain-source breakdown voltage $V_{GS}=0, I_D=250\mu\text{A}$	$V_{(\text{BR})\text{DSS}}$	100	-	-	V
Gate threshold voltage, $V_{GS} = V_{DS}$ $I_D=50\mu\text{A}$	$V_{GS(\text{th})}$	1.3	1.8	2.3	
Zero gate voltage drain current $V_{DS}=100\text{V}, V_{GS}=0, T_j=25^\circ\text{C}$	$I_{\text{DSS}}$	-	0.05	0.1	$\mu\text{A}$
		-	0.5	5	
Gate-source leakage current $V_{GS}=20\text{V}, V_{DS}=0$	$I_{GSS}$	-	10	100	nA
Drain-source on-state resistance $V_{GS}=4.5\text{V}, I_D=0.13\text{ A}$	$R_{\text{DS}(\text{on})}$	-	4.9	10	$\Omega$
Drain-source on-state resistance $V_{GS}=10\text{V}, I_D=0.17\text{A}$	$R_{\text{DS}(\text{on})}$	-	3.4	6	

**Electrical Characteristics**, at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

### Dynamic Characteristics

Transconductance	$g_{fs}$	$V_{DS} \geq 2 * I_D * R_{DS(on)max}$ $I_D = 0.13\text{A}$	0.08	0.17	-	S
Input capacitance	$C_{iss}$	$V_{GS} = 0, V_{DS} = 25\text{V},$ $f = 1\text{MHz}$	-	60	78	pF
Output capacitance	$C_{oss}$		-	8.6	11.2	
Reverse transfer capacitance	$C_{rss}$		-	3.1	4.1	
Turn-on delay time	$t_{d(on)}$	$V_{DD} = 50\text{V}, V_{GS} = 10\text{V},$ $I_D = 0.17\text{A}, R_G = 6\Omega$	-	2.7	4	ns
Rise time	$t_r$		-	3.1	4.6	
Turn-off delay time	$t_{d(off)}$		-	9.3	14	
Fall time	$t_f$		-	27	40	

### Gate Charge Characteristics

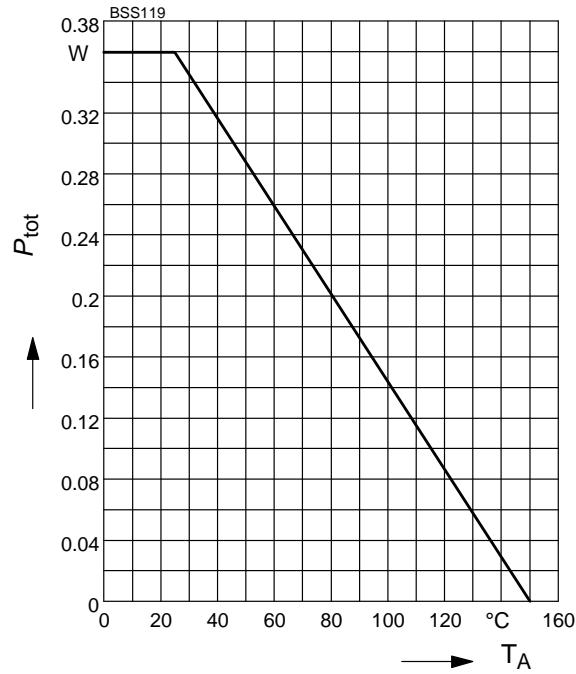
Gate to source charge	$Q_{gs}$	$V_{DD} = 80\text{V}, I_D = 0.17\text{A}$	-	0.08	0.12	nC
Gate to drain charge	$Q_{gd}$		-	0.76	1.1	
Gate charge total	$Q_g$	$V_{DD} = 80\text{V}, I_D = 0.17\text{A},$ $V_{GS} = 0 \text{ to } 10\text{V}$	-	1.67	2.5	
Gate plateau voltage	$V_{(plateau)}$	$V_{DD} = 80\text{V}, I_D = 0.17\text{A}$	-	3.4	-	V

### Reverse Diode

Inverse diode continuous forward current	$I_S$	$T_A = 25^\circ\text{C}$	-	-	0.17	A
Inv. diode direct current, pulsed	$I_{SM}$		-	-	0.68	
Inverse diode forward voltage	$V_{SD}$	$V_{GS} = 0, I_F = I_S$	-	0.8	1.2	V
Reverse recovery time	$t_{rr}$	$V_R = 50\text{V}, I_F = I_S,$ $di_F/dt = 100\text{A}/\mu\text{s}$	-	21.7	32.5	ns
Reverse recovery charge	$Q_{rr}$		-	10	15	nC

## 1 Power dissipation

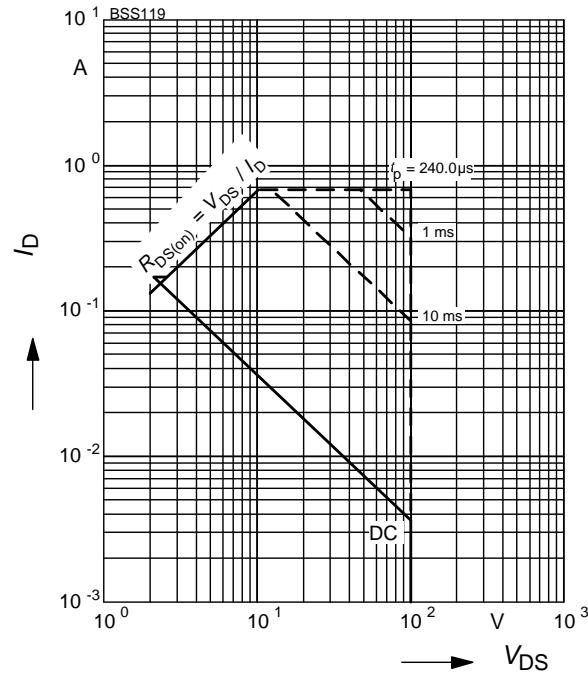
$$P_{\text{tot}} = f(T_A)$$



## 3 Safe operating area

$$I_D = f(V_{DS})$$

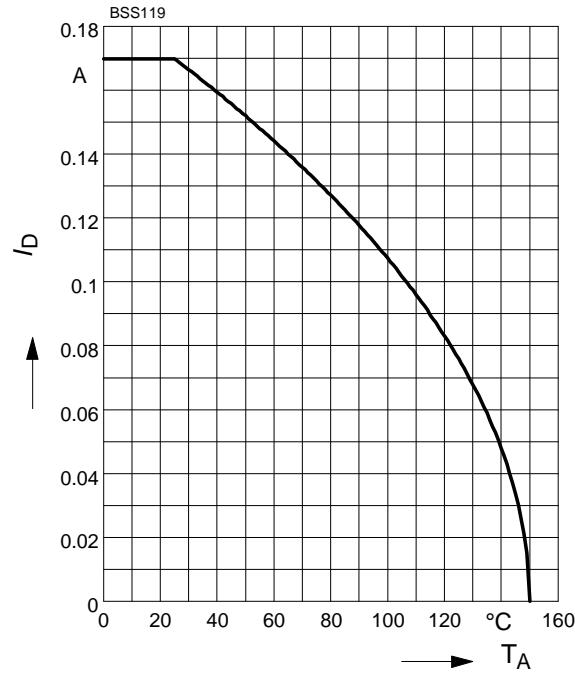
parameter :  $D = 0$ ,  $T_A = 25^\circ\text{C}$



## 2 Drain current

$$I_D = f(T_A)$$

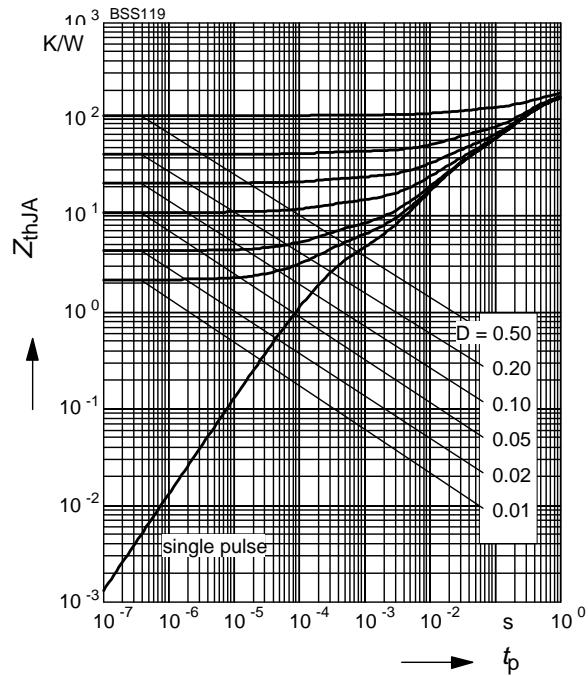
parameter:  $V_{GS} \geq 10\text{ V}$



## 4 Transient thermal impedance

$$Z_{\text{thJA}} = f(t_p)$$

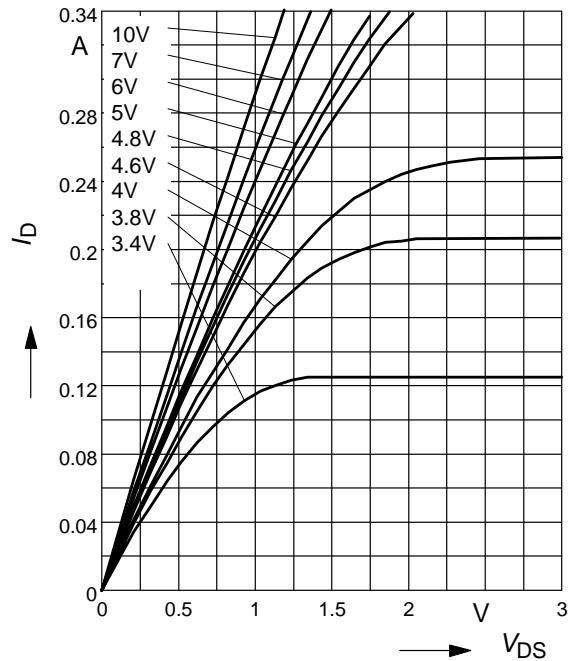
parameter :  $D = t_p/T$



### 5 Typ. output characteristic

$$I_D = f(V_{DS})$$

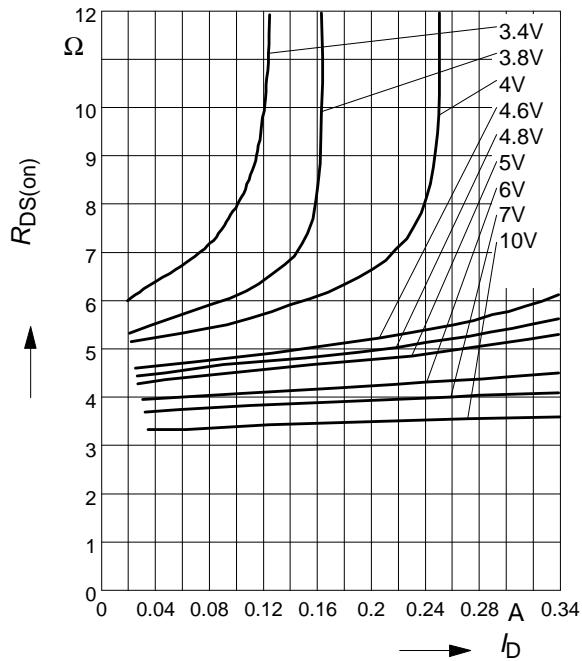
parameter:  $T_j = 25^\circ\text{C}$ ,  $V_{GS}$



### 6 Typ. drain-source on resistance

$$R_{DS(on)} = f(I_D)$$

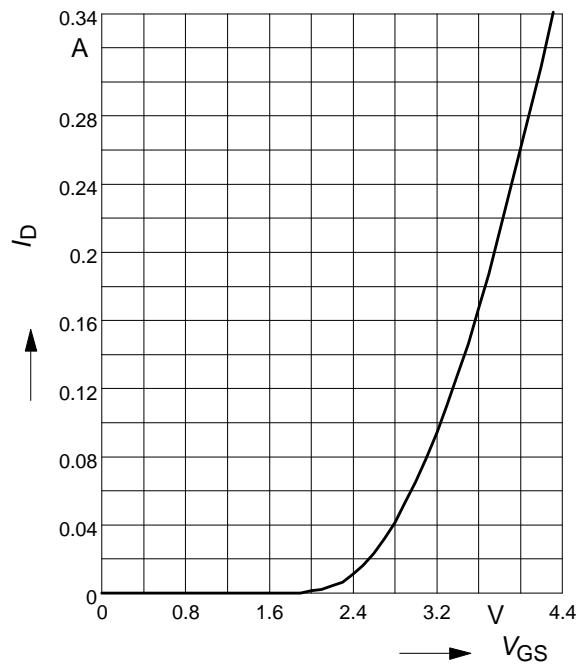
parameter:  $T_j = 25^\circ\text{C}$ ,  $V_{GS}$



### 7 Typ. transfer characteristics

$$I_D = f(V_{GS}); V_{DS} \geq 2 \times I_D \times R_{DS(on)\max}$$

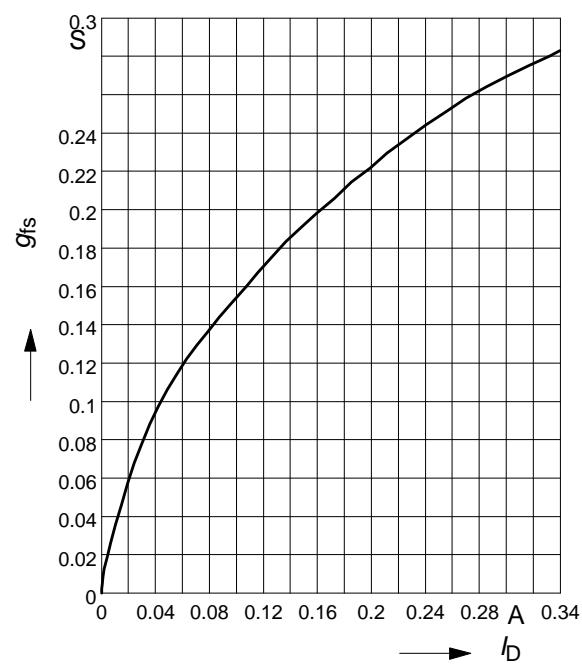
parameter:  $T_j = 25^\circ\text{C}$



### 8 Typ. forward transconductance

$$g_{fs} = f(I_D)$$

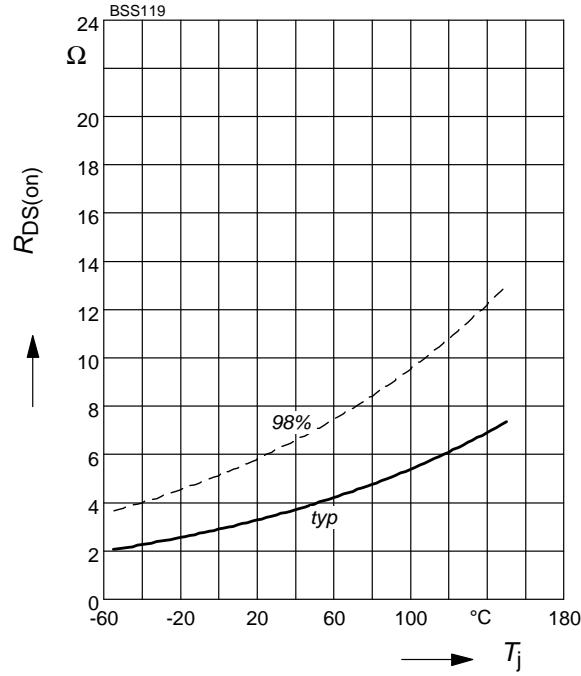
parameter:  $T_j = 25^\circ\text{C}$



### 9 Drain-source on-state resistance

$$R_{DS(on)} = f(T_j)$$

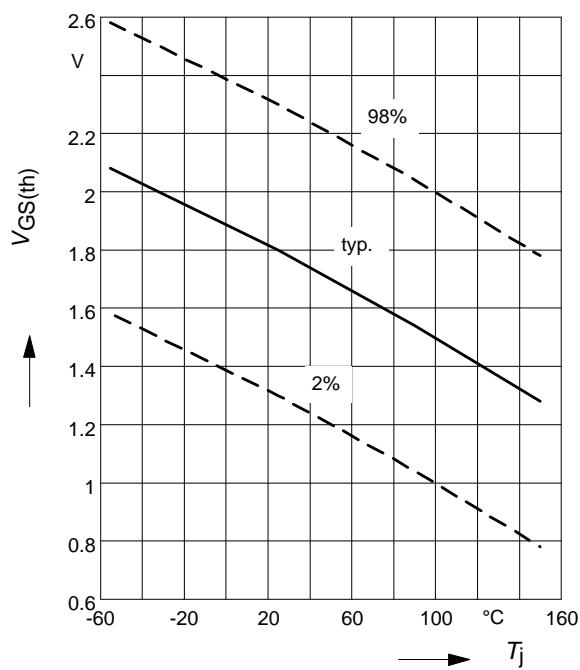
parameter:  $I_D = 0.17 \text{ A}$ ,  $V_{GS} = 10 \text{ V}$



### 10 Typ. gate threshold voltage

$$V_{GS(th)} = f(T_j)$$

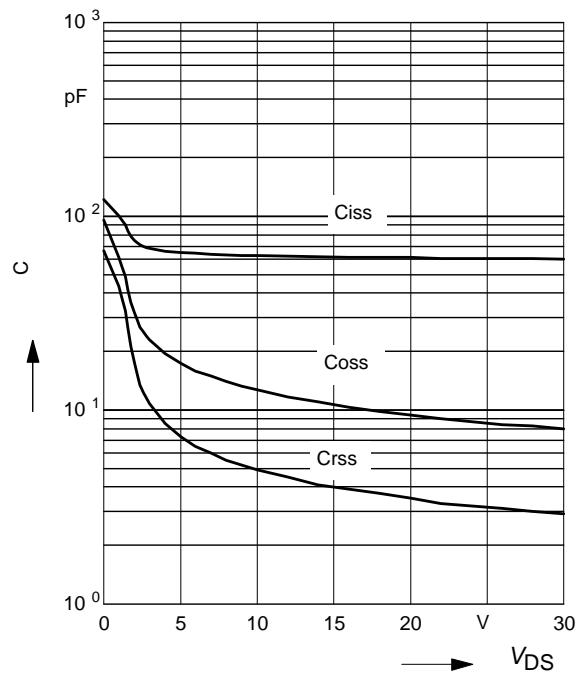
parameter:  $V_{GS} = V_{DS}$ ;  $I_D = 50 \mu\text{A}$



### 11 Typ. capacitances

$$C = f(V_{DS})$$

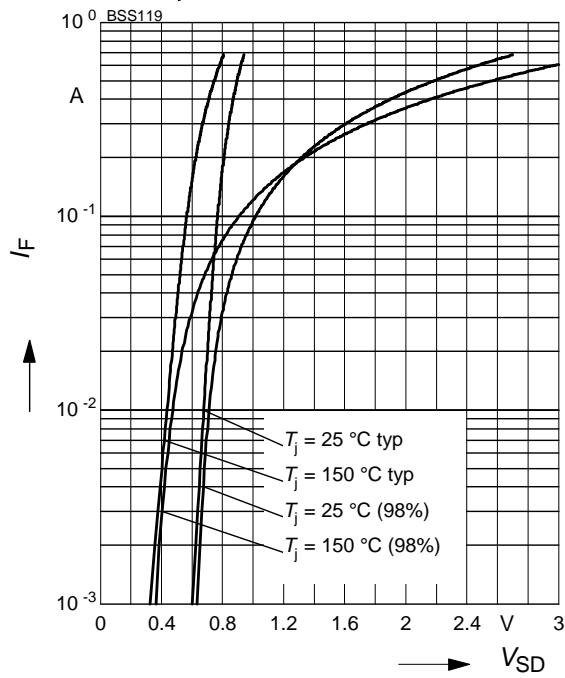
parameter:  $V_{GS}=0$ ,  $f=1 \text{ MHz}$ ,  $T_j = 25 \text{ }^\circ\text{C}$



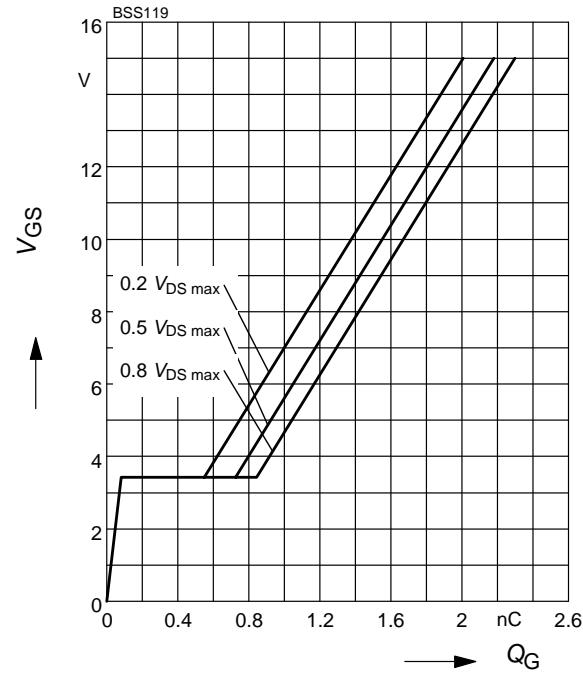
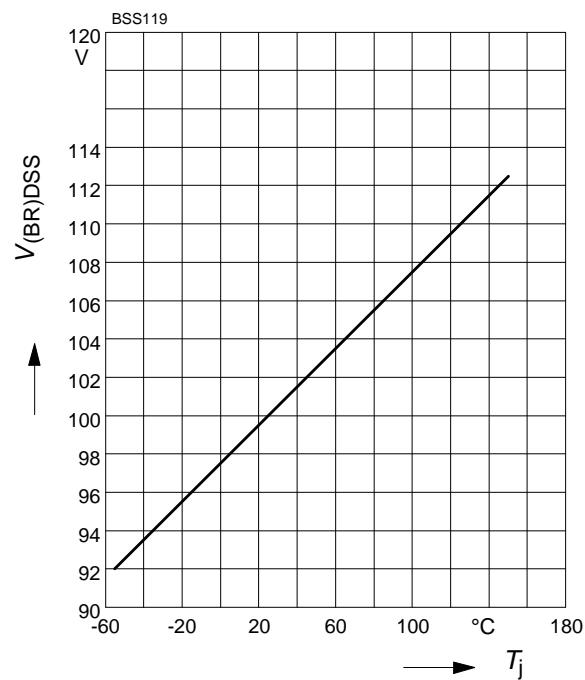
### 12 Forward character. of reverse diode

$$I_F = f(V_{SD})$$

parameter:  $T_j$



**13 Typ. gate charge**
 $V_{GS} = f(Q_G)$ ; parameter:  $V_{DS}$  ,

 $I_D = 0.17 \text{ A pulsed}, T_j = 25^\circ\text{C}$ 

**14 Drain-source breakdown voltage**
 $V_{(BR)DSS} = f(T_j)$ 


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